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## Novel organic semiconductor based on 2-aminoanthracene: synthesis, charge transporting and photoconductive properties<sup> $\dagger$ </sup>

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Anthracene is considered to be a popular choice as a building block for organic semiconductors. Present work is dedicated to synthesis and characterization of a novel semiconductor (**10-OPIA**) possessing mesogenic properties, which allows better control over charge transport in the bulk of material. Novel anthracene-based molecule is characterized for its potential applications: frontier molecular energy levels are studied by optical spectroscopy and cyclic voltammetry and confronted to values obtained via *ab initio* calculations. Thermophysical and mesogenic properties are investigated by optical microscopy and differential scanning calorimetry. Charge transporting properties are characterized by means of an OFET device. It is found that this material can be easily aligned and exhibits field effect hole mobility of  $5.22 \times 10^{-5} \text{ cm}^2/(\text{Vs})$  and ON/OFF ratio of  $10^4$  in the device prepared by drop casting. Finally, photoconductive properties of this novel material are addressed in order to investigate its potential applications to organic phototransistors: it exhibits large photoconductive gain of >100 and photo-responsivity of >1 A/W.

## <sup>2</sup> 1 Introduction

15 1 Organic electronics is a rapidly developing field of scientific research. In recent years, significant efforts have been devoted 17 4 to development of organic semiconductors (OSCs) for applica-5 tions such as field effect transistors (OFETs), light emitting diodes  $_{19}$ 6 (OLEDs) and photovoltaics (OPVs). These substances posses de- $_{20}$ 7 veloped  $\pi$ -conjugated structure which is the key to their charge  $_{_{21}}$ 8 transporting properties<sup>1</sup>. 9 22 Historically, one of the first evidence of charge transport in 10 organic molecules was discovered in anthracene crystals. Since 11 then, enormous progress has been made, and many other 12 molecules have been identified as promising organic semiconduc-13

14 tors. Nevertheless, anthracene still attracts significant attention

as a building block for the OSC materials.

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Indeed, the anthracene molecule presents a vast array of opportunities as a building block: large diversity of symmetric and asymmetric derivatives in end- (2, 3, 6, 7) as well as peri- (1, 4, 5, 8, 9, 10) positions has been synthesized and their charge transporting properties investigated over last decades<sup>2</sup>. Many attempts were made to increase the size of  $\pi$ -conjugated backbone by attaching aromatic fragments symmetrically to end positions (phenyl<sup>3</sup>, naphthalene<sup>4</sup>, anthracene<sup>5</sup>, thiophene<sup>6</sup>, etc.).

These efforts have proven the great potential of anthracene based molecules, and in addition to improving charge transport, significant efforts were dedicated to facilitate processing of these materials. Use of (triisopropylsilyl)ethynyl (TIPS) functional groups is a remarkable example of improvement of solubility, with a (9,10)-TIPS-functionalized molecule substituted with naphthalene in 2,6-positions which attained hole mobility  $\mu = 3.7 \, \text{cm}^2/(\text{V s})^7$ .

However the prerequisites which favor charge transport, such as strong  $\pi - \pi$  overlap expected to increase transfer integral and improve charge hopping from site to site may seem often result in an insoluble material thus significantly limiting its potential applications. Certain structural features, such as alkyl chains, are able to improve solubility as well as grant mesogenic properties to the material, which provides unique opportunities to control its structural properties in the form of thin film<sup>8</sup>. However, designing of a mesogenic molecule with a reasonable mesophase temper-

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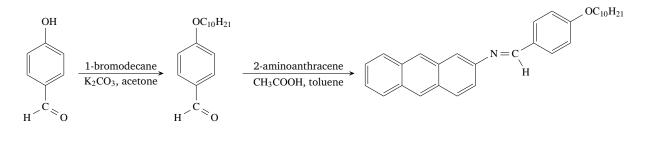
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Fig. 1 Synthesis of 10-OPIA.

ature range is not trivial. It is now of interest to address some as 41 anthracene-based liquid crystals which possess semiconducting 42 properties. Mery et al. have made a significant contribution to 43 the investigation of 2,6-substituted anthracene derivatives<sup>9</sup>: it 44 was found that direct attachment of flexible alkyl chains to the 45 end positions of anthracene is not sufficient to obtain mesomor-46 phic properties. Insertion of additional phenyl moieties between 47 the anthracene and alkyl spacer has allowed not only to increase 48 the overall flexibility of the molecule (which increases probability 49 to attain mesomorphic properties), but to additionally increase 50 the size of  $\pi$ -conjugated backbone. However, it is worth men-51 tioning that hole mobility measured in  $Sm_C$  and  $Sm_A$  mesophases <sup>95</sup> 52 were of about  $2 \times 10^{-3} \text{ cm}^2/(\text{Vs})$  at maximum, which is of the 53 same order of value as for phenyl naphthalene derivative 10 in 97 54  $Sm_B$  mesophase. In addition to relatively small gain in hole mobil-55 ity, the mesomorphic behaviour was exhibited on very high tem-56 100 perature (>  $200^{\circ}$ C). 57

An insoluble 2-substituted derivative of anthracene was pre-102 58 pared by Chen et al.<sup>11</sup>, which in addition to p-type transport-103 50 ing properties exhibits photosensitivity due to incorporation of an<sub>104</sub> azo-group. This substance has a relatively low mesophase transi-61 tion temperature (about 140 °C), which makes it more convenient<sub>106</sub> 62 to investigate its charge transport. The cooperative effects of UV-107 63 irradiation (molecular structure rearrangement) and thermal an-108 64 nealing (crystalline order improvement) have resulted in mobility<sub>109</sub> 65 increase from  $0.019 \,\mathrm{cm}^2/(\mathrm{Vs})$  to  $0.746 \,\mathrm{cm}^2/(\mathrm{Vs})$ . 66 110

We also wanted to explore the possibility of extending the  $\pi$ -111 67 conjugated backbone by employing imine linkage. This method 12 68 can be less demanding than formation of carbon - carbon bonds13 69 by usual methods such as Suzuki coupling (which requires inertaid 70 atmosphere, expensive precursors and catalysts). The purifica-115 71 tion of reaction products is also easier, as the only byproduct of 16 72 the reaction is water<sup>12</sup>. The resulting imine is isoelectronic to<sup>117</sup> 73 vinylene linkage<sup>13</sup>, which is commonly encountered in organic<sup>118</sup> 74 semiconductors. 75

In this work, we have developed an easy-to-synthesize semi-119 76 conductor which is based on inexpensive and readily available 20 77 precursors. We describe synthetic procedure and present some21 78 fundamental properties of the molecule: band gap energy, fron-122 79 tier molecular energy levels, thermo-physical properties. Charge123 80 transport is investigated by preparation of a field-effect transis-124 81 tor. Finally, we investigate photoconducting properties of the125 82 molecule in scope, which may be relevant for potential light-126 83 sensitive applications. 84 127

#### 2 Experimental section

1-bromodecane and 2-aminoanthracene were purchased from Alfa Aesar, 4-hydroxy-benzaldehyde was purchased from Sigma Aldrich. All chemicals were used as received without further purification. NMR analysis was performed on Bruker Avance III 400 MHz spectrometer. Mass spectrum was recorded on Agilent 6540 UHD Q-TOF LC/MS system. DFT calculations were performed with the help of Gaussian 16, Rev. A03 software<sup>14</sup>. Optical absorption spectroscopy was performed on Perkin Elmer Lambda 2 spectrometer with dilute  $(10^{-5} \text{ M})$  solution in dichloromethane in a standard quartz cuvette with optical path of 1 cm on a range from 230 nm to 500 nm. Fluorescensce spectrum was obtained on Cary (Agilent) Eclipse spectrometer. Fluorescence decay was measured on Horiba DeltaFlex TCSPC Lifetime Fluorometer. Cyclic voltammetry was performed with Metrohm AUTOLAB PGSTAT302. 2 mmol/L solution of 10-OPIA in dichloromethane containing 0.1 M of tetrabutylammonium hexafluorophosphate (TBAPF<sub>6</sub>) as a supportive electrolyte was stirred for 2h and then placed in the electrochemical cell (10 ml volume). The solution was degassed by Ar bubbling for 20 minutes. Cyclic voltammograms were collected in the range from -2.2 to 1.8 V against silver wire pseudoreference with scanning speeds ranging from 50 to 500 mV/s. After collection of 10-OPIA voltammograms, 2 ml of 1 mmol solution of ferrocene (98%, Sigma Aldrich) in supporting electrolyte was injected in the cell and degassed for 20 minutes prior to measurements. Additional data was recorded to include the potential range of Fc/Fc+ oxidation process. The data of ferrocene oxidation was further used to extract its halfwave potential (mean value between the anodic and cathodic peaks, since Fc/Fc+ process is quasi-reversible) and use it as a reference point<sup>15</sup> for the previously obtained data for **10-OPIA**. Differential scanning calorimetry (DSC) was performend on TA Instruments Q1000. Electrical emeasurements were performed with two Keysight B2901 SMUs.

#### 2.1 Synthetic route

We have developed a new molecule ((E)-N-(anthracen-2-yl)-1-(4-(decyloxy)-phenyl)methanimine or **10-OPIA**, Figure 1) which can be prepared easily from commercially available materials: the phenyl moiety is attached to anthracene by an imine linkage which can be obtained by a simple nucleophilic addition between 2-aminoanthracene and 4-alkyloxy-benzaldehyde derivatives. The length of terminal flexible chain can be efficiently controlled by choosing an appropriate alkyl halide precursor.

#### 128 Alkylation of 4-hydroxy-benzaldehyde

0.31 g (2.5 mmol) of 4-hydroxy-benzaldehyde was placed in a<sup>183</sup> 129 round bottom flask with 0.66 g (3 mmol) of 1-bromo-decane.<sup>184</sup> 130 0.41 g (3 mmol) of K<sub>2</sub>CO<sub>3</sub> was added to the reaction mixture. Fi-131 nally, 15 ml of acetone were introduced, and the mixture was set 132 to reflux with stirring for 48 h. After the reaction was finished, the 133 acetone was evaporated under reduced pressure and the crude185 134 4-decyloxy-benzaldehyde (PDBA, Figure 1) was purified by col-186 135 umn chromathography with a mixture of dichloromethane and<sup>187</sup> 136 hexane  $\sim 1:1 \text{ v/v}$  ratio. This procedure allowed us to recover 137 0.53 g of PDBA which corresponds to 82% yield. <sup>1</sup>H-NMR (400<sup>188</sup> 138 MHz, CDCl<sub>3</sub>)  $\delta$  = 9.87 (s, 1H); 7.81 (d, J = 8.4 Hz, 2H); 6.98 (d, 139 J = 8.3 Hz, 2H); 4.03 (t, J = 6.6 Hz, 2H); 1.80 (quint, J = 6.8 Hz, 140 2H); 1.46 (m, 2H); 1.30 (m, 12H); 0.88 (t, J = 6.9 Hz, 3H) ppm 141 (Figure 1 of ESI<sup>†</sup>). 142

#### 143 Imine synthesis

0.53 g (2 mmol) of the purified PDBA with 0.39 (2 mmol) g of 144 2-amino-anthracene (2-AA) were placed in a round bottom flask. 145 The initial products were dissolved in 25 ml of toluene, and a few 146 drops of glacial acetic acid were introduced as a catalyst. The 147 reaction mixture is allowed to reflux with stirring for 48 h. The 148 final product precipitated from the reaction mixture upon cooling, 149 and was filtered and washed with cold toluene and further with 150 acetone to remove toluene. The crude 10-OPIA was dried in the 151 oven and then recrystallized in minimal amount of chloroform. 152 Finally, we have obtained 0.55 g of 10-OPIA which corresponds 153 to 57% yield. <sup>1</sup>H-NMR (400 MHz, CDCl<sub>3</sub>)  $\delta$  = 8.58 (s, 1H); 154 8.41 (d, J = 2.6 Hz, 2H); 8.02 (m, 3H); 7.91 (d, J = 8.7 Hz, 2H); 155 7.70 (d, J = 1.5 Hz, 1H); 7.52-7.39 (m, 3H); 7.01 (d, J = 8.7 Hz, 156 2H); 4.04 (t, J = 6.6Hz, 2H); 1.82 (quint, J = 6.6Hz, 2H); 1.48 157 (*m*, 2H); 1.30 (*m*, 12H); 0.89 (*t*, J = 6.9 Hz, 3H) ppm. <sup>13</sup>C-NMR 158  $(100 \text{ MHz}, \text{CDCl}_3) \delta = 162.1, 159.8, 149.6, 132.5, 132.2, 131.5,$ 159 130.8, 130.5, 129.4, 129.2, 128.4, 128.1, 126.3, 126.1, 125.7, 160 125.2, 122.2, 117.0, 114.9, 68.4, 32.1, 29.7, 29.6, 29.5, 29.3, 161 26.2, 22.8, 14.3 ppm. <sup>1</sup>H and <sup>13</sup>C NMR spectra are shown in 162 Figures 2 (a) and (b) of ESI<sup>+</sup>. HRMS (ESI+Q-TOF) calculated for 163 [C31H36NO]<sup>+</sup> 438.2791, found 438.2790. This molecule is stable 164 in solid state: we have compared the NMR spectra after 8 months 165 of storage in ambient conditions and no traces of degradation 166 were detected. 167 192

#### 168 Device fabrication

The OFET devices in bottom gate - bottom contact were fabri-194 169 cated by utilizing commercially available substrates provided by<sup>195</sup> 170 Ossila (Sheffield, UK) fabricated on heavily doped silicon wafer<sup>196</sup> 171 with thermally grown  $SiO_2$  (300 nm) as gate insulator and evapo-<sup>197</sup> 172 rated Au source and drain contacts. Before deposition, substrates<sup>198</sup> 173 were washed with Decon<sup>™</sup> 90 solution, deionized water, acetone<sup>199</sup> 174 and isopropanol for 5 mins in succession. The substrates were<sup>200</sup> 175 further subjected to UV-Ozone cleaning for 20 min. The chan-201 176 nel dielectric layer (SiO<sub>2</sub>) was functionalized with self-assembled<sup>202</sup> 177 monolayer (SAM) of octadecyltrichlorosilane (OTS-18) solution203 178 in hexadecane for 30 min, then substrates were washed with chlo-204 179 roform. The semiconductor was deposited by drop-casting from205 180 0.5% chlorobenzene solution on inclined substrate in saturated206 181

vapor conditions in order to obtained ordered films. Hole mobility was calculated from source-drain current  $I_{DS}$  in saturation regime by using the following equation:

$$I_{DS} = \left(\frac{W}{2L}\right) \mu_F C_i \left(V_{GS} - V_{th}\right)^2,\tag{1}$$

where *W* is the channel width and *L* is the channel length,  $C_i$  is the capacitance per unit area of the gate dielectric,  $\mu_F$  is the field-effect mobility and  $V_{th}$  is the threshold voltage.

#### 3 Results and discussion

DFT computation of molecular structure

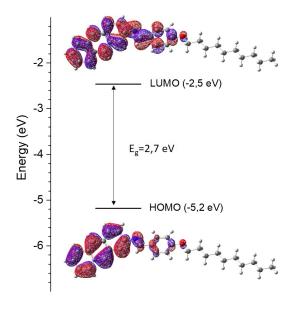


Fig. 2 Frontier molecular orbitals of the 10-OPIA molecule, calculated on B3LYP/6-31G++(d,p) level. MO energy levels are extracted from cyclic voltammetry data.

Molecular geometry of **10-OPIA** was obtained through DFT optimization at B3LYP/6-31G++(d,p) level of theory. Optimized structure had zero imaginary frequencies. Calculated geometries of frontier molecular orbitals are presented in the Figure 2. It is of interest to note the distribution of electron density over  $\pi$ -conjugated backbone: the HOMO of this molecule seems to be mostly localized on the electron-rich anthracenyl moiety. The initial estimation of the band gap (3.3 eV) is performed by subtracting calculated energy levels of HOMO (-5.3 eV) and LUMO (-2.0 eV). The close proximity of HOMO energy level (-5.3 eV) to the work function  $\phi$  of Au (about -5.1 eV) allows us to expect shallow barrier for hole injection from the Au electrode, as well as ambient air stability due to its deep localization.

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We have further investigated electronic properties of **10-OPIA** molecule by optical spectroscopy and cyclic voltammetry. Characterization of thermophysical and mesogenic properties can be found in ESI<sup>†</sup>.

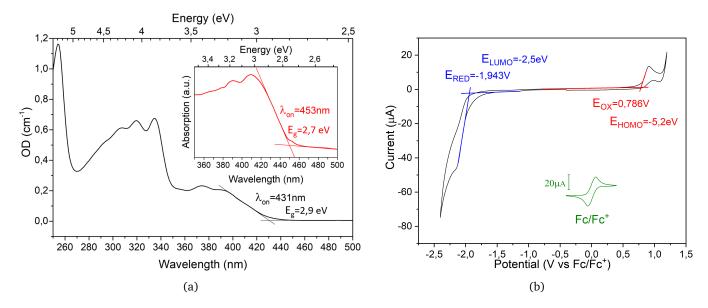


Fig. 3 (a) Absorption spectra of 10-OPIA in dichloromethane solution. Inset: Absorption spectrum in thin film form. (b) Cyclic voltammograms of 10-OPIA solution and Fc/Fc+ reference (vertical offset added for clarity).

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#### Optical spectroscopy 207

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Optical band gap, corresponding to the first electronic transition<sup>242</sup> 208  $(S_0 \rightarrow S_1, \text{HOMO} \rightarrow \text{LUMO})$  was extracted from the onset of op-243 209 tical absorption by drawing a tangent at the first absorption band<sub>244</sub> 210 as illustrated in Figure 3, (a). 211 245

Absorption spectrum in solid state was recorded for a thin246 212 film of 10-OPIA which was deposited on a quartz slide by drop-247 213 casting. It was found that 10-OPIA exhibits a red shift of 22 nm248 214 when in thin film (inset of Figure 3, a), which may be explained249 215 by more pronounced  $\pi - \pi$  interactions of neighboring molecules 50216 in the crystalline phase as opposed to that of in solution, which251 217 results in a band gap energy reduction for the bulk 10-OPIA. 252 218 By utilizing the relation  $E = \frac{hc}{\lambda}$ , where *E* is the energy, *h* is the 219 Planck's constant and  $\lambda$  is the wavelength; the optical band gap is 220 calculated to be  $E_g = 2.9 \,\text{eV}$  for the onset of absorption of 431 nm 221 in dichloromethane solution, and  $E_g = 2.7 \,\text{eV}$  for the onset of 222 absorption of 453 nm in the form of solid thin film, respectively. 223 Both of these values are noticeably smaller than initial estimation253 224 from ab initio calculations. 254

It is well-known that compounds containing imine linkage<sup>255</sup> 226 show little to no light emitting properties  $^{12}$ . However,  $10^{-5} M^{256}$ 227 solution of 10-OPIA in acetone (degassed by freeze-pump-thaw<sup>257</sup> 228 method on a Schlenck line) was weakly fluorescent (Figure 5 (a)258 229 of ESI<sup>†</sup>). Emission peak is situated at 480 nm (excitation wave-<sup>259</sup> 230 length - 435 nm). Similarly, fluorescence lifetime measurements<sup>260</sup> 231 were carried out in acetone solution with excitation at 370 nm.<sup>261</sup> 232 Unusually high lifetime (9.44 ns) indicates some hindering of the<sup>262</sup> 233 rotation around imine linkage axis, which is the preferred way of 234 non-radiative relaxation for this type of materials. Possible rea-235 sons include interaction between lone electron pair on the nitro-236 gen atom and anthracenyl  $\pi$ -conjugated system due to nonpla-237 nar geometry of the molecule (dihedral angle between anthra-238 cenyl and phenyl structures is about 140°). Similar effect was 239 observed by Yoshino et al. 16 for molecules with constrained azo-240

and imine linkages, which resulted in enhancement of fluorescence.

#### Cyclic voltammetry

Cyclic voltammetry was employed to experimentally estimate frontier MO energy levels<sup>17</sup>. Figure 3, (b) depicts a cyclic voltammogram of 10-OPIA solution recorded at 50 mV/s referenced versus Fc/Fc+ redox couple (in blue). Two tangents were drawn (in red) at the reduction and oxidation parts of the data in order to determine the onsets  $E_{RED}$  and  $E_{OX}$  on their intersection with the background current tangent. These extracted potentials were employed to evaluate the HOMO and LUMO energy levels of 10-**OPIA** using the following relations<sup>17</sup>:

$$E_{HOMO} = -(E_{OX} + 4.4), eV$$
 (2)

$$E_{LUMO} = -(E_{RED} + 4.4), eV$$
 (3)

which allows us to estimate  $E_{IUMO} = -2.5 \,\text{eV}$  and  $E_{HOMO} =$  $-5.2 \,\mathrm{eV}$ . These values look reasonable in regards to the band gap estimated by absorption spectroscopy. Moreover, the HOMO level of -5.2 eV appears to be in good agreement with DFT calculations (Table 1), confirming our initial guess for good affinity of 10-**OPIA** material with Au contacts as a p-type semiconductor.

Taking into account the experimental results from cyclic voltammetry, we find the electrochemical band gap energy  $(E_{HOMO}-E_{LUMO}) E_{gEC} = 2.7 \text{ eV}$  to be in good agreement with the

Table 1 Comparison of band gap and MO values of 10-OPIA between B3LYP/6-31G++(d,p) level of theory (DFT) and electrochemistry (CV).

Method	$E_{HOMO}$ (eV)	$E_{LUMO}$ (eV)	$E_g$ (eV)
DFT	-5.3	-2.0	3.3
CV	-5.2	-2.5	2.7

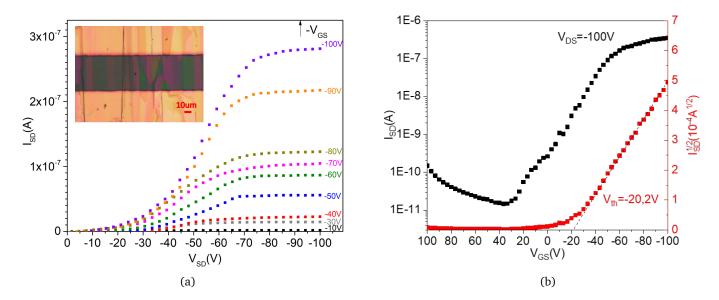


Fig. 4 (a) Output characteristic of an OFET (L =  $50 \mu$ m, W=18 mm) prepared with 10-OPIA. Inset: photo of channel region. (b) Transfer characteristic and  $V_{th}$  of the same device.

value  $E_{gO} = 2.7 \text{ eV}$  obtained for a thin solid film of **10-OPIA** by<sub>296</sub> absorption spectroscopy. Experimentally obtained HOMO level is<sub>297</sub> in good agreement with its theoretical value, however the energy<sub>298</sub> level of LUMO is noticeably underestimated (about 0.5 eV), which<sub>299</sub> is the reason of band gap energy overestimation.

Cyclic voltammograms of 10-OPIA recorded at different scan-301 268 ning rates are assembled in Figure 6 of ESI<sup>+</sup>. It is possible to ob-302 269 serve distinct features corresponding to the electrochemical oxi-303 270 dation and reduction of 10-OPIA molecules. The peak positions04 271 are independent to the scanning speed, while the recorded cur-272 rent is proportional to it. The asymmetric profile of oxidation 273 indicates irreversibility of these two processes related to the in-274 stability of oxidized/reduced 10-OPIA species in solution. 275 308

#### 276 Charge transport properties

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<sup>277</sup> We have carried out current-voltage measurements on **10-OPIA<sup>311</sup>** <sup>278</sup> OFET in air and at room temperature to characterize the charge<sup>312</sup> <sup>279</sup> transport of this new material. Our deposition technique has<sup>313</sup> <sup>280</sup> allowed us to grow relatively big crystals (greater than chan-<sup>314</sup> <sup>281</sup> nel length) in the direction favorable for charge transport ( $\pi - \pi^{315}$ <sup>282</sup> stacking plane normal to electrodes). <sup>316</sup>

Inset of Figure 4, (a) shows magnification of transistor channel<sup>317</sup> area in inter-digitated (IE) geometry (L =  $50 \,\mu$ m, W =  $18 \,\text{mm}$ )<sup>318</sup> with deposited **10-OPIA** thin film, which reveals large crystalline<sup>319</sup> domains crossing both (source and drain) electrodes. The yield<sup>320</sup> of 17 working devices out of 20 per substrate on average was<sup>321</sup> achieved. <sup>322</sup>

The device was characterized in ambient air conditions. The<sup>323</sup> output characteristic of **10-OPIA** OFET in inter-digitated config-<sup>324</sup> uration is presented in the Figure 4, (a). This device demon-<sup>325</sup> strates characteristic features of a field-effect transistor: drain-<sup>326</sup> source current is proportional to the negative gate voltage, and<sup>327</sup> the curve has two distinct regions: quasilinear on lower voltage<sup>328</sup> and saturation on higher voltage. Field effect hole mobility is<sub>329</sub> calculated from the saturation part of the drain-source current:  $\mu = (2.6 \pm 1.2) \times 10^{-5} \text{ cm}^2/(\text{V s})$ . Mobility values extracted for devices in linear configuration (L =  $30 \mu \text{m}$ , W = 1mm) showed slightly higher hole mobility  $\mu = (4.1 \pm 2.7) \times 10^{-5} \text{ cm}^2/(\text{V s})$  (output and transfer characteristics of linear OFET can be found in Figure 11 of ESI†). We may speculate that longer channel ( $50 \mu \text{m}$  vs  $30 \mu \text{m}$ ) results in higher amount of structural micro-defects in **10-OPIA** layer, which may be responsible for lower average mobility.

The hole mobility value is comparable to that obtained by Chung et al.<sup>7</sup> for symmetrical 9,10-TIPS functionalized antracene derivatives substituted in 2,6- positions with phenylene vinylene  $(\mu = (5.21 \pm 3.55) \times 10^{-5} \text{ cm}^2/(\text{Vs}))$  and hexyl thiophene  $(\mu =$  $(2.05\pm1.17)\times10^{-6}\,\text{cm}^2/(V\,s))$  in thin film form. It should be noted that these reported results were obtained for devices in bottom gate/top contact (BGTC) configuration, which usually exhibits better results<sup>18</sup> than that of bottom gate/bottom contact geometry (used in this work). It is also of interest to compare  $\mu_{hole}$  of **10-OPIA** to other asymmetrical anthracene derivatives. Recently, F. Qiu et al.<sup>19</sup> provided a comparative study where they have varied the linkage between the phenyl and anthracenyl moieties. It was demonstrated that for thermally evaporated polycrystalline films in BGTC configuration the hole mobility varied between  $0.89\,\text{cm}^2/(\text{V}\,\text{s})$  for vinyl and  $5.56\times 10^{-5}\,\text{cm}^2/(\text{V}\,\text{s})$  for ethynyl linkage. Single crystal OFET mobilities for these materials accounted only for one order of magnitude difference between these two materials, which indicates the profound influence of molecular geometry on the bulk material behaviour. For 10-OPIA, torsion between phenyl and anthracenyl moieties may result in inter-molecular packing which is less optimal for charge transport. That is in contrast with 2-(phenylvinyl)anthracene based molecule characterized by A. Dadvand et al.<sup>20</sup>, even though these two molecules have isoelectronic  $\pi$ -conjugated core.

Performance of OFETs is typically affected by high contact re-

sistance related to imperfect injection of charge carriers into the363 330 channel. It is well known that even closely matched  $\phi$  of con-364 331 tact material and MO level as in the case of Au/pentacene may365 332 exhibit substantial (0.6 eV) hole injection barrier<sup>21</sup>. Additionabee 333 steps may be implemented to decrease contact resistance such assor 334 contact functionalization with SAMs or deposition of oxide inter-368 335 layer<sup>22</sup> to tune metal work function<sup>18</sup> for optimal hole injection.369 336 The transfer characteristic and threshold voltage of 10-OPIA370 337 OFET in linear configuration are presented in the Figure 4, (b).371 338 Transfer characteristic allows us to extract the ON/OFF ratio (10<sup>4</sup>)<sup>372</sup> 339 of the device. The threshold voltage for this device is found to373 340 be -20.2 V (-27.6 V in linear configuration). We would like to<sup>374</sup> 341 underline a relatively low threshold voltage obtained with 10-375 342 OPIA material for this fabrication method (drop casting), which376 343 in some cases may be greater than  $-50 \,\mathrm{V}^{23}$ . 344 Interestingly, thermal annealing of devices did not result in im-378 345 provement of carrier mobility, but in contrary it dramatically de-379 346 graded their performance: by examining the substrates under op.380 347 tical microscope, we have found that annealing on temperatures<sup>381</sup> 348 above 80 °C results in apparition of significant amount of cracks<sup>382</sup> 349

in the channel area, which act as structural defects and impede383 350 351 charge transport. 384 385

#### Photoconductive properties 352

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During the initial testing of devices fabricated with 10-OPIA, we<sub>388</sub> 353 have noticed pronounced photosensitivity of 10-OPIA material to 354 3300K light. To further investigate this phenomena, we have  $em_{390}$ 355 ployed a 455 nm (bandwidth FWHM = 18 nm) light source (vari-391 356 able power LED) which corresponds to the edge of absorption  $for_{392}$ 357 10-OPIA in a solid film form (inset of Figure 3, a). 358 393

Figure 5 represent the transfer characteristic of previously de-394 359 scribed OFET device under irradiation of varying power density.395 360 We would like to underline how the current  $I_{SD}$  is amplified by<sub>396</sub> 361 incident light, while retaining distinct ON and OFF states. 362 397

1E-5 399 1E-5 (A) 400 1E-6 401 1E-6 402 403 1E-7 1E-7 404 0,00 0,25 0,50 0,75 1,00 405 Light intensity Light intensity 406  $(mW/cm^2)$ 0 mW/cm<sup>2</sup> 407 0.27 mW/cm<sup>2</sup> 1E-9 408 0,56 mW/cm<sup>2</sup> 0,80 mW/cm<sup>2</sup> 409 1E-10 1,16 mW/cm<sup>2</sup> 410 V<sub>DS</sub>=-100V 411 1E-11 412 100 80 60 40 20 0 -20 -40 -60 -80 -100  $V_{GS}(V)$ 413

Fig. 5 Plot of transfer characteristic of an OFET prepared with 10-414 OPIA for different illumination intensities. Illumination wavelength is415  $\lambda$ =455 nm, V<sub>SD</sub> = -100V. Inset: Plot of saturation drain-source current<sub>416</sub> as a function of light intensity. 417

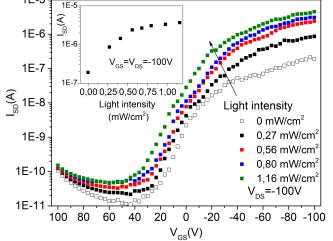
In addition to conventional parameters (field effect mobility, threshold voltage, ON/OFF ratio), phototransistors are characterized by two additional parameters: photosensitivity P (ratio of photocurrent to dark current) and responsivity R (factor of proportionality of photocurrent to incident light power). We present these parameters in the Figure 6, (a). It is of interest to notice how responsivity gradually increases with negative gate voltage and follows the transfer characteristic of OFET. This parameter exceeds 1 A/W at higher gate voltages, which may be considered reasonably high when compared to typical organic materials<sup>24,25</sup> and even some inorganic semiconductors<sup>26</sup>. Symmetrical anthracene derivative studied by Li et al. 27 demonstrated responsivity between 1 and 10 A/W in the form of poly-crystalline thin film. Single crystal devices generally demonstrate much higher performance, as in the case of alkyl-thienothiophene-substituted anthracene<sup>28</sup> where responsivity exceeded 3000 A/W.

The photosensitivity of this device is found to be maximal at intermediate gate voltage, which is directly related to a significant decrease of threshold voltage under illumination due to photogating effect (from  $V_{th}$  = -20.2V to +20.3V), and decreases on higher gate field values (where ISD increases in dark conditions), stabilizing around 100. This may be explained by taking into account that the process of photoexcitation is somewhat similar to the field effect in regard to the increase in local density of charge carriers. The more than two order increase observed for current amplitude may indicate filling of significant amount of trap states by photogenerated carriers. In cooperation with field effect it may bring the device closer to the regime where the source-drain current becomes contact-limited<sup>29</sup>. Visible saturation of  $I_{SD}$  as a function of illumination power (inset of Figure 5) confirms this observation.

It is of interest to compare this behavior with the work published by Pal et al.<sup>30</sup>, where a field effect transistor prepared with poly(3-hexylthiophene) (P3HT) in bottom gate/bottom contact configuration showed high performance under illumination. The ON/OFF ratio degraded significantly upon illumination (about 2 orders) which is in distinct contrast with our case. For 10-OPIA OFET, the ON/OFF ratio upon illumination is found to be almost unchanged from dark conditions (around 10<sup>4</sup>) even on relatively high illumination power (greater than  $1 \text{ mW/cm}^2$ , Figure 12 of ESI<sup>†</sup>) which may indicate a relatively high recombination barrier for photogenerated electrons. A larger band gap of 10-OPIA (as compared to that of P3HT) allows this device with Au electrodes to retain its p-channel character even upon significant illumination ("photo-doping"). Another possible explanation involves substantial difference between electron and hole mobilities in the bulk of 10-OPIA, which limits the number of photogenerated electrons participating in the channel current. This may explain large photoinduced gain of OFET's transfer curve on the majority of gate voltage range.

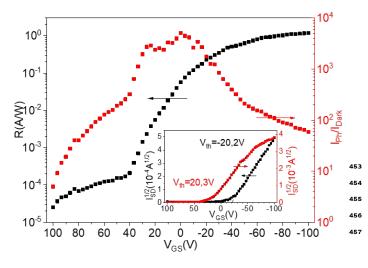
#### Persistent photoconductivity

Before we continue our investigations of photoconductive properties of 10-OPIA, it is necessary to explain the nature of this large photoconductive gain. As we have mentioned, subjection of 10-OPIA to incident light results in the increase of channel con-



ductivity (photoconductive effect) and threshold voltage reduc-447 418 tion (photogating effect): (i) Incident light creates electron-hole448 419 pairs in the semiconductor, which become separated under ap-449 420 plied electric field V<sub>DS</sub> and participate in the increase of source-450 421 drain current (Figure 13 of ESI<sup>+</sup>). This effect is responsible for451 422 conductivity boost and positive photocurrent. (ii) Photogating452 423 effect is responsible for the aforementioned change of the thresh-424 old voltage upon illumination (inset of Figure 6). This effect is 425 explained by the presence of trap states such as structural defects 426

on 10-OPIA/SiO<sub>2</sub> interface, for example (on the edge of LUMO
"band" in the Figure 13 of ESI<sup>†</sup>, which become populated upon
irradiation). The contribution of these charged states acts as an
additional local "gate" electric field and is able to noticeably shift
the threshold voltage of a device<sup>31</sup>, especially if we take into account weak field screening in the bulk of material due to its organic nature.



**Fig. 6** Plot of photoresponsivity as a function of gate voltage ( $V_{SD}$  = -100V) at incident power 1.44 mW/cm<sup>2</sup> (black squares) and photo-458 sensitivity (photocurrent to dark current ratio, in red) measured for an<sub>459</sub> OFET in inter-digitated configuration. **Inset:** Threshold voltage of the same device in dark (black squares) conditions and under irradiation (red squares).

The resulting photoconductive gain *G* is expressed by following equation  $^{29}$ :

$$G = \frac{c\tau_{pc}}{\tau_{tr}} = \frac{c\tau_{pc}\mu V}{L^2},\tag{4}^{466}$$

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where  $\tau_{pc}$  is the lifetime of photogenerated charge carriers,  $\tau_{lr}$ is the transit time, c is the concentration of successfully dissociated into electrons and holes light-induced excitons,  $\mu$  is the<sup>467</sup> mobility of majority carriers, V is the applied voltage and L is the<sup>468</sup> distance between two electrodes. In the case of photogating, the<sup>469</sup>  $\tau_{pc}$  is limited by the recombination of carriers residing in the trap<sup>470</sup> states.

#### <sup>443</sup> Field effect dependency of persistent photoconductivity

We have performed transient photoconductivity measurements in#74 order to better understand the recombination behavior of these475 "gating" states, which has led us to another interesting property476 of **10-OPIA** - persistent photoconductivity (PPC): sample exhibits higher conductivity in dark condition after being irradiated with light. Figure 7 serves to illustrate this phenomena: the sample is illuminated for 180 s with  $1.16 \,\mathrm{mW/cm^2}$  of 455 nm light, which yields higher dark current after the light source is turned off as compared to initial dark state.

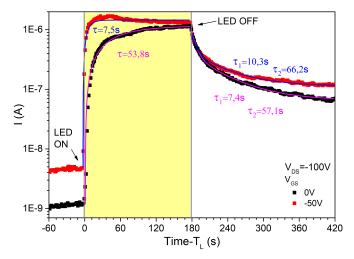


Fig. 7 Plot for current as a function of time.  $V_{DS} = -50V$ ,  $V_{GS} = 0V$  (black symbols),  $V_{GS} = -50V$  (red symbols).  $T_L$  - start of illumination.

Interestingly, gate bias has pronounced effect on the transient photoconductivity. We have noticed that photo-OFET reacts significantly faster while the gate is being negatively biased than in unbiased state. Photocurrent increase may be fitted with a single exponential growth function:

$$I = I_0 \left[ 1 + \exp\left(\frac{t - t_0}{\tau}\right) \right],\tag{5}$$

where  $I_0$  is the initial current (vertical offset),  $t_0$  is the horizontal offset, and  $\tau$  is the response time. Application of moderate voltage (V<sub>GS</sub> = -50V) results in almost one order decrease of saturation time for the photocurrent (7.5s vs 53.8s). This result may be attributed to faster filling of trap states with photogenerated carriers, as well as improved exciton dissociation on the semiconductor/dielectric interface.

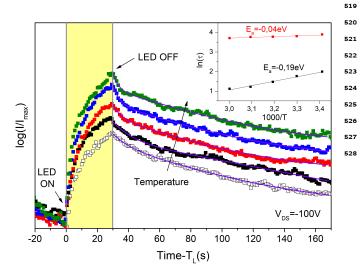
The decay part of PPC is affected by gate bias as well. It can be fitted with double exponential decay function:

$$I = I_0 + I_1 \exp\left(-\frac{t-t_0}{\tau_1}\right) + I_2 \exp\left(-\frac{t-t_0}{\tau_2}\right),$$
(6)

where  $I_{1,2}$  are the pre-exponential factors and  $\tau_{1,2}$  are the relaxation times. It appears that in our case persistent dark current has two components: a fast and a slow relaxation time. This behavior is encountered in polycomponent<sup>32–34</sup> as well as pure materials<sup>35</sup>. Some researches attribute the existence of two decay time components to two different energy levels of trap states: deeper traps are considered to recombine slower<sup>26,36</sup>, contrary to more shallow trap states. Some materials show PPC decay with single exponential component, as perylene tetracarboxylic diimide (PTCDI)<sup>37</sup>. Similarly to photocurrent growth, the decay

of PPC is demonstrates its dependence on gate bias. By com-477 paring the extracted relaxation times (Figure 7) we find that the 478 sample under continued negative V<sub>GS</sub> shows slightly slower cur-479 rent decay ( $\tau_1 = 10.3$  vs 7.4s,  $\tau_2 = 66.2$  vs 57.1s). We have also 480 noticed that positive gate bias has detrimental effect on PPC, as 481 the measured current reverts to values similar to the state before 482 irradiation. To better understand these experimental results, we 483 should consider the following: (i) As demonstrated for photocur-484 rent growth, current saturates significantly faster under negative 485 gate voltage, which for same duration of illumination may result 486 in higher occupancy ratio of persistent states. Prolonged periods<sup>509</sup> 487 of illumination have also shown noticeable increase in both time  ${}^{{}^{\mathfrak{slo}}}$ 488 components of current decay, which supports this suggestion. (ii)<sup>511</sup> 489 The gate bias seemingly improves charge separation on the semi-<sup>512</sup> 490 conductor/dielectric interface or even allow the photogenerated<sup>513</sup> 491 charge carriers to access energy states which are unavailable at<sup>514</sup> 492  $V_{GS}=0V$ , due to band bending. This delays the recombination of 493 516 populated trap states, thus increasing their lifetime. 494 517

495 Temperature dependency of PPC



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**Fig. 8** Plot for normalized photocurrent as a function of time and temperature. Vertical offset is introduced for clarity.  $V_{SD} = -100V$ ,  $V_{GS} = 0V$ . Purple lines represent double exponential fit.  $T_L$  - start of illumination. **Inset:** Arrhenius plot of persistent conductivity decay time component. Black squares correspond to  $\tau_1$ , red squares correspond to  $\tau_2$ .

In order to investigate the difference between trap state energy 496 levels which we have encountered in PPC decay, we have per-497 formed another series of experiments where we have measured 498 the PPC decay time components as a function of temperature. We 499 have performed measurements in a temperature range from 20 °C 500 to 60 °C. Figure 8 assembles transient current plots for differ-501 ent temperatures. Every measurement was preceded by 5s pulse 502 of positive gate voltage ( $V_{GS}$ =50V) which is sufficient to "erase" 503 persisting photoconductive states. Current was measured during 504 30s of illumination, then additional 140s of current decay were 505 recorded. The data was then normalized in respect to the peak 506 photocurrent and the decay part was fitted with the equation 5. 507 The extracted decay time components are assembled in the Ta-508

Table 2 Time components extracted from data presented in Figure 8.

Temperature (°C)	$\tau_1$ (s)	$\tau_2$ (s)
20	6.7	49.1
30	5.8	44.5
40	4.4	43.7
50	3.4	43.1
60	3.1	41.6

ble 2. The exponential PPC decay times increase as the temperature decreases. However, it seems that faster decay component  $\tau_1$  is affected stronger than the slower  $\tau_2$ . Tokumoto *et al.*<sup>35</sup> have performed investigations on TIPS-functionalized pentacene, which exhibited similar persistent photoconductivity properties. As in our case, PPC decay time was found to be inversely proportional to the temperature. However, this dependency was found to be more pronounced in the case of TIPS-pentacene than in the case of **10-OPIA**. This may be explained by relatively low energy trap states in a semiconductor with a smaller bad gap (about 1.9 eV for TIPS-pentacene versus 2.7 eV for **10-OPIA**).

We have calculated activation energy  $E_a$  from Arrhenius plot for both decay time components (inset of Figure 8). The extracted value for fast decay component ( $E_a(\tau_1)=0.19 \text{ eV}$ ) is fives times greater than for slow decay component ( $E_a(\tau_2)=0.04 \text{ eV}$ ). The value of  $E_a(\tau_1)$  is slightly larger than that extracted for PTCDI<sup>37</sup> ( $E_a=0.14 \text{ eV}$ ).

Direct comparison of these two time components allows us to conclude that slower decay component  $\tau_2$  is indeed connected to deeper trap states, which energetic disorder is less affected by

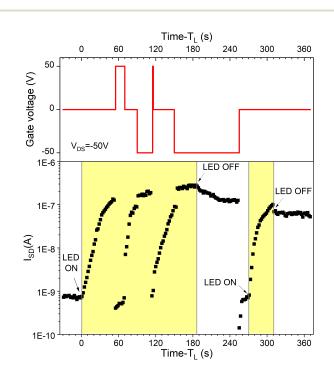


Fig. 9 Plots for OFET channel current (bottom) and gate voltage (top) as a function of time. Irradiation power was  $1.16 \, \mathrm{mW/cm^2}$  at 455nm. T<sub>L</sub> - start of illumination.

temperature increase, as compared to traps characterized by  $\tau_{1584}$ (their shallow energy level allows thermal detrapping)<sup>38</sup>.

The presence of these deep trap states allows us to propose<sup>585</sup> 531 some thermal stability of photoconductive properties, which mayses 532 be exploited in potential applications of **10-OPIA** material. Inser 533 combination with the flexibility of device response with respect to 534 gate voltage, we may propose use of this material in phototransis-588 535 tors (pronounced photoresponsivity  $R \sim 1 \text{ A/W}$  and photogating 536 effect), photodetectors and optoisolators (response time may besso 537 reduced with smaller channel length and higher gate bias) and 538 memory devices (long persistent photoconductivity decay times,592 539 positive gate voltage "erases" persistent state). 593 540

Figure 9 demonstrates the channel current plot as a function of 541 time, illumination and gate voltage. The device is initially illumi-542 nated at zero gate bias, and the current begins to rise relatively595 543 slowly. After 50 seconds, positive voltage ( $V_{GS}$ =50V) is applied, 596 544 which results in immediate breakdown of photocurrent to values 545 below initial (before illumination). We restore zero gate bias af-598 546 ter 20 seconds, which allows current amplitude to recover in the 547 same manner as in the beginning of illumination. After 85 sec-600 548 onds under light, we apply negative gate bias ( $V_{GS}$ =-50V), which<sub>601</sub> 549 results in immediate saturation of photocurrent. 30 seconds later 550 short pulse (1s) of positive voltage is applied, which resets the, 551 photocurrent in a similar manner. After the recovery of photocur-552 rent, the gate is once again turned to -50V, however this time, 553 we let the photocurrent saturate for 30 seconds and then turn off 554 the LED in order to observe decay of persistent photoconductiv-555 ity. After about one minute we remove gate bias ( $V_{GS}=0V$ ), which 556 to our surprise acts similarly to application of positive field - the 557 persistent photoconductivity effect is removed. Further part of 558 the plot demonstrates persistent effect in absence of gate voltage 559 modulation. 560 612

### 561 4 Conclusion

In this work we have described a novel semiconducting material,<sup>614</sup> 562 from synthesis to possible application. The incorporation of het-563 eroatom (nitrogen) in  $\pi$ -conjugated system of this new molecule 564 makes it easier to synthesize, since no carbon-carbon bonds need<sup>617</sup> 565 to be formed when being prepared from commercial precursors.<sup>618</sup> 566 The resulting substance is air-stable, which is an important advan-619 567 tage over classic semiconducting materials based on polyacenes. 620 568 We have employed optical spectroscopy and cyclic voltammetry<sup>621</sup> 569 to characterize frontier molecular orbital energy levels as well as<sup>622</sup> 570 band gap energy. Favorable HOMO level of 10-OPIA allowed us<sup>623</sup> 571 to prepare a p-type transistor. We have developed a simple pro-624 572 tocol of deposition for 10-OPIA, which has allowed us to prepare625 573 OFETs in bottom gate/bottom contact configuration, as well as to<sup>626</sup> 574 control preferable direction of crystal growth. 627 575 Finally, we have characterized photoconductive properties of 628 576 this material. We have encountered large photoconductive gaine29 577 (~ 100) and photoresponsivity ( $R \sim 1 \text{ A/W}$ ) for OFETs based on<sub>630</sub> 578 **10-OPIA** despite relatively high channel length ( $50 \mu m$ ). These 31

**10-OPIA** despite relatively high channel length  $(50\,\mu\text{m})$ . These devices have also demonstrated non-negligible photogating effects<sup>32</sup> which in connection to remarkable control of over photoconduc<sup>33</sup> tivity via gate bias allows us to suggest further investigations of this new class of materials in relation to photosensitive applica<sup>35</sup> tions.

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#### Conflicts of interest

The authors declare that there is no conflict of interest regarding the publication of this article.

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